Department of Electronic and Telecommunication Engineering University of Moratuwa, Sri Lanka

EN4603 - Digital IC Design



Laboratory Experiment 1 RTL Synthesis

Laboratory Report

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\mathbf{Li}	st o	of Abbreviations							
AS	SIC A	Application Specific Integrated Circuit							
GI	PDK	Generic Process Design Kit							
ні	OL H	Iardware Description Language							
RTL Register-Transfer Level									
TC	CL T	ool Command Language							

Note:

All the materials related to the report can also be found at ht tps://github.com/b imal ka 98/D ig it al-IC-D es ig n

1 Introduction

1.1 Practical

In this practical, we will be using Cadence Genus - Ver. 18.10 to synthesize an example RTL design, a transceiver. As inputs to Genus, we will provide

- 1. Source Verilog files
- 2. Technology libraries provided by the fabrication plant (here, 45 nm educational Generic Process Design Kit (GPDK) given by Cadence): (.lib, .lef, .tch)
 - Library Timing (.lib) files specify timing (cell delay, cell transition time, setup and hold time requirement) and power characteristics of standard cells. Slow and fast libraries characterize standard cells with maximum and minimum signal delays, which could occur from process variations.
 - Tch files are binary files that accurately characterize library elements, that include capacitance and resistance.
 - Library Exchange Format (LEF) specify design rules, metal capacitances, layer information...etc.

3. Timing constraints

and will obtain the synthesized netlist (Verilog files) and further timing constrains (.sdc) as output. We will then analyze the area, timing and power of the synthesized design.

1.2 RTL Synthesis

In the context of digital hardware design, RTL synthesis is the process of converting an RTL description of a digital circuit into an optimized gate-level design.

The RTL description of a digital circuit is written in a Hardware Description Language (HDL) such as Verilog or VHDL. It specifies the digital circuit in terms of the flow of digital signals between registers, and the logical operations that are performed on those signals as they are transferred between the registers.

During RTL synthesis, an RTL compiler reads the RTL description of the digital circuit and generates an optimized gate-level representation of the circuit. This gate-level representation is a description of the digital circuit in terms of gates and interconnections between them. Figure 1 illustrates an overview of an RTL synthesis flow.

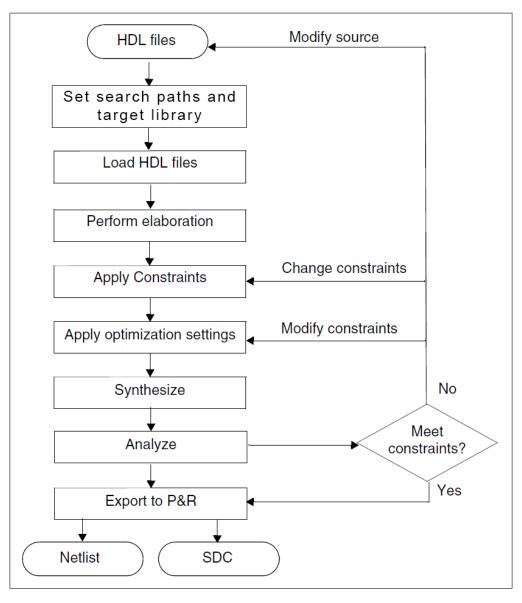


Figure 1: Overview of RTL synthesis flow of Cadence Genus software[1].

1.3 Associated Genus Commands

Note: Genus is a Tool Command Language (TCL) based tool and therefore .tcl scripts can be created to execute a series of commands instead of typing each command individually. The entire interface of Genus is accessible through TCL, and true TCL syntax and semantics are supported.

Followings are the commands used in this lab, and the entire script could be executed once using a single .tcl file. However, it was encouraged to execute the commands one-by-one in order to understand the process of synthesizing an RTL design.

```
# 1. Link Technology Library
set_db init_lib_search_path [list ../input/libs/gsclib045/lef
    ../input/libs/gsclib045/timing ../input/libs/gsclib045/qrc/qx]
set_db library {slow_vdd1v0_basicCells.lib fast_vdd1v0_basicCells.lib}
set_db lef_library {gsclib045_tech.lef gsclib045_macro.lef
    gsclib045_multibitsDFF.lef}
set_db qrc_tech_file gpdk045.tch
# 2. Read HDLs
read_hdl [glob ../input/rtl/*.v]
# 3. Elaborate the top module
elaborate uart_top
# 4. Check Design
check_design > ../log/check_design.log
# 5. Uniquifies the instances under the specified design or subdesign.
uniquify uart_top
# 6. Set constraints
source ../input/constraints.tcl
# 7. Synthesize
synthesize -to_mapped -effort m
# 8. Write netlist
write -mapped > ../output/uart_top.v
write_sdc > ../output/uart_top.sdc
# 9. Reports
report_area > ../report/area.log
report_timing -nworst 10 > ../report/timing.log
report_constraint > ../report/constraint.log
report_port * > ../report/ports_final.log
report_power > ../report/power.log
```

2 Exercise

This section documents the observations made in step 4 and 5 of the practical guide, with screenshots and explanations.

2.1 System Clocks & Resets

2.1.1 System Clocks

The specifications related to the system clocks and other constraints are defined in the constraints.tcl script file, which can be executed once using the Genus software. The units of the clocks, and the other parameters related to timings are in nanoseconds (ns) scale, as defines in the Verilog source files by timescale 1ns/1ps.

The command create_clock[2] is used to define the clocks, and the necessary parameters related to them.

```
create_clock -name clk_a -period 10 [get_ports clk_a] -waveform {0 5}
create_clock -name clk_b -period 10 [get_ports clk_b] -waveform {0 5}
```

The clocks specified in the constraints file has the properties described in the Table 1. In addition to those properties, constraints related to the clock network uncertainty is also defined in the same file. In practical Application Specific Integrated Circuit (ASIC) design, ideal clock networks do not exist and clock signal arrival time may differ from cell to cell. In order to facilitate this, a parameter known as *clock uncertainty* is defined. It takes into account all the possible variations of the clock signal such as 1. *jitter*, which is caused by the physical properties of the clock source, and 2. *skew*, which is due to the routing length variations.

The set_clock_uncertainty[2] command is used to define the clock uncertainty as below.

```
set_clock_uncertainty 0.5 [all_clocks]
```

Table 1 Properties of the system clocks. (time unit = ns)

Name	Period	eriod Rise Time Fall Time		Clock Uncertainty
clk_a	10	0	5	0.5
clk_b	10	0	5	0.5

2.1.2 System Resets

Two system reset signals are defined in the top module uart_top.v Verilog source file, as reset_a and reset_b. Both resets are synchronous and active high.

```
always@(posedge clk) begin
   if (reset) begin
     some statements;
   end
end
```

2.1.3 Derived Clocks

A derived clock (a new clock signal) can be created from the clock waveform of a given pin in the design using the command create_generated_clock[2]. However, the given design for this lab does not in cooperate any derived clocks.

2.2 Design Log Files

2.2.1 Area

area.log file in the report directory carries the information shown in the Figure 2. It provides a breakdown of the area usage by design hierarchy and by instance, which can be helpful in identifying specific modules that are contributing to the overall area of the design. Specifically it provides the below information[2].

- i. **Cell Count**: The total count of cells mapped against the hierarchical blocks in the current design.
- ii. Cell Area: The combined cell area in each of the blocks and the top level design (hierarchical breakup)
- iii. **Net Area**: The estimated post-route net area, which is based on the minimum wire widths defined in the LEF and capacitance table files and the area of the design blocks.
- iv. Total Area: Simply combines the 'Cell Area' and the 'Net Area'

Instance	Module	Cell Count	Cell Area	Net Area	Total Area
art_top		772	2220.948	946.493	3167.44
ins_uart_transceiver_B	uart_transceiver_CLOCK_IN_MHZ100_TX_WORD_LENGTH8_T	386	1110.474	423.318	1533.79
ins_rx_wrapper	rx_wrapper_NO_OF_WORS_IN_BUFFER1_NO_OF_DATA_BITS8_	197	621.072	209.103	830.17
ins_rx_buffer	rx_buffer_WORD_SIZE8_NO_OF_WORDS1_1	67	292.068	61.047	353.11
ins_rx_fsm	rx_fsm_NO_OF_DATA_BITS8_PARITY_ENABLED32h54525545_	74	180.918	77.867	258.78
ins_sampling_tick_generator	sampling_tick_generator_BAUD115200_CLOCK_IN_MHZ100	56	148.086	62.149	210.23
ins_tx_wrapper	<pre>tx_wrapper_NO_OF_WORDS_IN_BUFFER1_NO_OF_DATA_BITS8</pre>	189	489.402	214.215	703.61
ins_tx_fsm	tx_fsm_NO_OF_DATA_BITS8_PARITY_ENABLED32h54525545_	94	210.330	103.544	313.87
ins_tx_buffer	tx_buffer_WORD_SIZE8_NO_OF_WORDS1_1	53	146.718	52.247	198.96
ins_sampling_tick_generator	sampling_tick_generator_BAUD115200_CLOCK_IN_MHZ100	42	132.354	46.412	178.76
ins_uart_transceiver_A	uart_transceiver_CLOCK_IN_MHZ100_TX_WORD_LENGTH8_T	386	1110.474	423.318	1533.79
ins_rx_wrapper	rx_wrapper_NO_OF_WORS_IN_BUFFER1_NO_OF_DATA_BITS8_	197	621.072	209.103	830.17
ins_rx_buffer	rx_buffer_WORD_SIZE8_NO_OF_WORDS1	67	292.068	61.047	353.11
ins_rx_fsm	rx_fsm_NO_OF_DATA_BITS8_PARITY_ENABLED32h54525545_	74	180.918	77.867	258.78
ins_sampling_tick_generator	sampling_tick_generator_BAUD115200_CLOCK_IN_MHZ100	56	148.086	62.149	210.23
ins_tx_wrapper	<pre>tx_wrapper_NO_OF_WORDS_IN_BUFFER1_NO_OF_DATA_BITS8</pre>	189	489.402	214.215	703.61
ins_tx_fsm	tx_fsm_NO_OF_DATA_BITS8_PARITY_ENABLED32h54525545_	94	210.330	103.544	313.87
ins_tx_buffer	tx_buffer_WORD_SIZE8_NO_OF_WORDS1	53	146.718	52.247	198.96
ins sampling tick generator	sampling tick generator BAUD115200 CLOCK IN MHZ100	42	132.354	46.412	178.76

Figure 2: Area log file

2.2.2 Power

power.log file in the report directory carries the details shown in the Figure 3. It provides the information related to the power consumption; however, the returned information depends on the current position in the design hierarchy and on the specified objects. If no objects are specified, the report is given for the design or instance at the current position in the design hierarchy[2].

i. Leakage power refers to the power that is consumed by the circuit even when it is in a quiescent or standby state. This type of power consumption is caused by the leakage current flowing through the transistors and other components in the circuit.

- ii. Dynamic power refers to the power that is consumed by the circuit when it is actively switching or performing computations. This type of power consumption is caused by the charging and discharging of the load capacitance at the inputs and outputs of the transistors.
- iii. Total power is the sum of leakage power and dynamic power, it is the overall power consumed by the circuit.

		Leakage	Dynamic	Total
Instance	Cells	Power(nW)	Power(nW)	Power(nW)
uart top	772	60.819	172490.052	172550.870
ins_uart_transceiver_B	386	30.415	87250.682	87281.098
ins_rx_wrapper	197	19.437	60900.810	60920.247
ins_rx_buffer	67	11.235	44449.732	44460.967
ins_rx_fsm	74	5.135	11368.789	11373.924
<pre>ins_sampliick_generator</pre>	56	3.067	5082.288	5085.355
ins_tx_wrapper	189	10.979	26349.873	26360.851
ins_tx_fsm	94	5.124	14188.375	14193.500
ins_tx_buffer	53	3.228	7822.657	7825.885
ins_sampliick_generator	42	2.626	4338.840	4341.466
ins_uart_transceiver_A	386	30.403	80046.763	80077.167
ins_rx_wrapper	197	19.422	54041.240	54060.663
ins_rx_buffer	67	11.223	37609.104	37620.327
ins_rx_fsm	74	5.146	12300.830	12305.977
<pre>ins_sampliick_generator</pre>	56	3.053	4131.306	4134.359
ins_tx_wrapper	189	10.981	26005.523	26016.504
ins_tx_fsm	94	5.117	13676.204	13681.321
ins_tx_buffer	53	3.232	8467.156	8470.388
ins_sampliick_generator	42	2.632	3862.163	3864.795

Figure 3: Power log file

2.2.3 Timing

2.2.4 Ports

Bibliography

- [1] "Genus User Guide for Legacy UI," version 19.1, November 2019, published by *Cadence Design Systems, Inc.
- [2] "Genus Command Reference," version 19.1, November 2019, published by $Cadence\ Design\ Systems,\ Inc.$